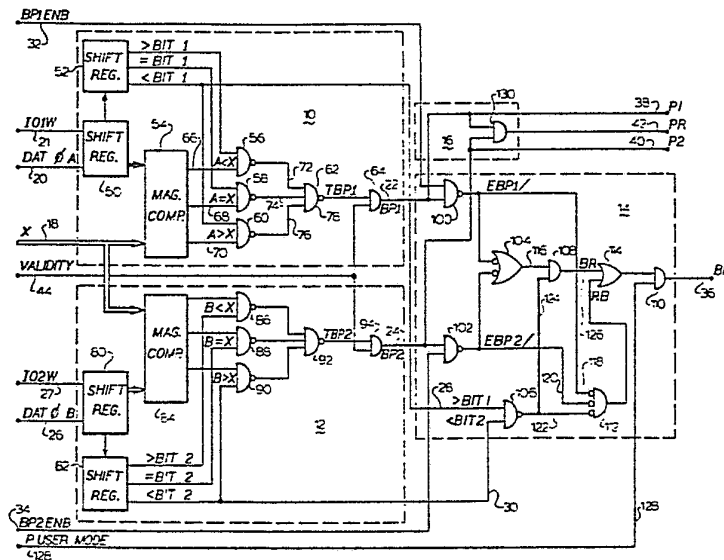




INTERNATIONAL APPLICATION PUBLISHED UNDER THE PATENT COOPERATION TREATY (PCT)

<p>(51) International Patent Classification <sup>3</sup>: <b>G06F 7/00, 7/22, 9/00</b></p>	<p>A1</p>	<p>(11) International Publication Number: <b>WO 81/03078</b> (43) International Publication Date: 29 October 1981 (29.10.81)</p>
<p>(21) International Application Number: PCT/US80/00446 (22) International Filing Date: 22 April 1980 (22.04.80)</p> <p>(71) Applicant: RELATIONAL MEMORY SYSTEMS, INC. [US/US]; Post Office Box 6719, San Jose, CA 94086 (US).</p> <p>(72) Inventors: KELLEY, James, M.; 800 Saratoga Avenue, San Jose, CA 95127 (US). COURY, Fred, F.; 1278 Mandarin Drive, Sunnyvale, CA 94087 (US).</p> <p>(74) Agent: HAMRICK, Claude, A.S.; Suite 200, 3211 Scott Boulevard, Santa Clara, CA 95051 (US).</p>	<p>(81) Designated States: CH (European patent), DE (European patent), DK, FR (European patent), GB (European patent), JP, SE (European patent), SU.</p> <p><b>Published</b> <i>With international search report</i></p>	

(54) Title: RELATIONAL BREAK SIGNAL GENERATING DEVICE



(57) Abstract

A relational break signal generating device including two relational comparators (10) and (12) which independently compare an address input from a microprocessor to reference addresses previously input thereto and generate output signals which are fed into a combinational logic circuit (14) that produces false and break signals when a prespecified relationship between the input program address and the two reference addresses occurs. The device also includes a circuit (16) for generating pulses each time a break point is detected.

**FOR THE PURPOSES OF INFORMATION ONLY**

Codes used to identify States party to the PCT on the front pages of pamphlets publishing international applications under the PCT.

<b>AT</b>	Austria	<b>KP</b>	Democratic People's Republic of Korea
<b>AU</b>	Australia	<b>LI</b>	Liechtenstein
<b>BR</b>	Brazil	<b>LU</b>	Luxembourg
<b>CF</b>	Central African Republic	<b>MC</b>	Monaco
<b>CG</b>	Congo	<b>MG</b>	Madagascar
<b>CH</b>	Switzerland	<b>MW</b>	Malawi
<b>CM</b>	Cameroon	<b>NL</b>	Netherlands
<b>DE</b>	Germany, Federal Republic of	<b>NO</b>	Norway
<b>DK</b>	Denmark	<b>RO</b>	Romania
<b>FI</b>	Finland	<b>SE</b>	Sweden
<b>FR</b>	France	<b>SN</b>	Senegal
<b>GA</b>	Gabon	<b>SU</b>	Soviet Union
<b>GB</b>	United Kingdom	<b>TD</b>	Chad
<b>HU</b>	Hungary	<b>TG</b>	Togo
<b>JP</b>	Japan	<b>US</b>	United States of America

- 1 -

## Specification

"Relational Break Signal  
Generating Device"

BACKGROUND OF THE INVENTION5 Field of the Invention

The present invention relates generally to apparatus used in the field of computer-based system debugging, and more particularly to a relational break signal generating device for monitoring the execution of a  
10 computer program and causing the suspension of execution of that program and/or the initiation or termination of external processes as a function of the memory and/or I/O operations being performed by the programmer.

Description of the Prior Art

15 There has long been a need for apparatus capable of monitoring the execution of a computer program and halting the program and/or triggering external processes as a function of the execution of the program. One prior art method used is to replace a particular program instruction with a halt instruction so that if the computer  
20 tries to execute the instruction that normally resides at that particular point in the program, the execution sequence will be caused to stop and indicate the attempted instruction execution. This allows the programmer to run the program to a certain point and then examine the  
25 results of execution up to that point. By judicious replacement of certain instructions with the halt instructions, the programmer can thus control and monitor the execution of a program.

30 The problem with this prior art technique is that it cannot be used in software in which the program is stored in ROMs since it is not possible to replace an instruction in a ROM with a halt instruction.



Another prior art method is to place an instruction in the monitored program which will cause the computer to jump to a control program and allow easier access to memory. However, the problem with this  
5 technique is that the frequent jumping to a control program to log certain types of data, or to check and see if a break point condition has occurred, means that the program is not allowed to run in real time.

The present invention extends the concept of break  
10 point control to that of (a) relational breaks and (b) between limits breaks (break regions). Relational breaks are defined to include the following:

- (1) If  $X = A$ , then break.
- (2) If  $X > A$ , then break.
- 15 (3) If  $X < A$ , then break.
- (4) If  $X \geq A$ , then break.
- (5) If  $X \leq A$ , then break.

Thus, the equality break point (Case 1) is the most simple case of a relational break. Note that for  
20 efficiency of hardware realization, Cases 4 and 5 may be achieved by letting  $A = A' + 1$ , in which case Case 4 is equivalent to Case 2, and letting  $A = A' - 1$ , wherein Case 5 is equivalent to Case 3.

In the industry, break points are used to facilitate  
25 software debugging, hardware debugging and software/hardware debugging. The break point concept is used in logical analyzers (hardware), in-circuit emulation (hardware), monitors (computer program), debug executives (computer program) and the front panel of computers.

30 The generalization concept of break point to include relational points and breaks and break regions greatly improves the ability of an engineer to debug software, debug hardware, or debug hardware/software systems and make performance measurements within the  
35 computer system. The use of the relational break

-3-

concept for software debugging increases the ability of the computer programmer to locate malfunctioning software by permitting him to establish a "window" around the portion of the computer program that is malfunctioning and then to "close in on the error" until the part of the program which is malfunctioning is located. This is to be contrasted with the use of a break point which requires considerably more user interaction and may necessitate single step execution of the program. In some cases it is practically impossible to use break point to determine an error due to the real time constraints within which the program must be executed.

The use of relational and regional breaks for hardware debugging is very powerful in the detection of intermittent hardware failure which causes the hardware to cease proper program execution erratically and unpredictably. Break points cannot be effectively used for this purpose because that technique requires that one know in advance where to place the break point.

20

#### SUMMARY OF THE PRESENT INVENTION

It is therefore a principal object of the present invention to provide a relational break signal generating device which can monitor a program during its execution and cause the suspension of execution of that program and/or the initiation or termination of external processes when a prespecified program event occurs.

Another objective of the present invention is to provide a device of the type described which operates in real time and does not require that a program under test be modified in any way to implement the monitoring operation.

Still another object of the present invention is to provide a device of the type described which uses combinational logic to recognize predetermined relational conditions.



-4-

Briefly, a preferred embodiment of the present invention includes two relational comparators, the inputs of which each includes a specifiable reference address, the address lines from a microprocessor and several  
5 qualifying inputs. The comparators independently compare the address from the microprocessor to the reference address input thereto and generate output signals which are fed into a combinational logic circuit which produces false and break point signals when a prespecified rela-  
10 tionship between the input program address and the two reference addresses occurs. Although the present invention has general application, the particular preferred embodiment disclosed is embodied in a microcomputer in-circuit emulator and is used to generate  
15 pulses and/or cause program break points under specified conditions.

An important advantage of the present invention is that it allows any computer program to be monitored on a real time basis.

20 Another advantage of the present invention is that it allows the occurrence of specified events during program execution to be counted or cause signals to be developed which will interrupt execution of the program.

25 These and other advantages of the present invention will no doubt become apparent to those skilled in the art after having read the following detailed description of the preferred embodiment which is illustrated in the drawing.

#### IN THE DRAWING

30 The Figure is a diagram schematically illustrating a relational break signal generating device in accordance with the present invention.



DETAILED DESCRIPTION OF THE PREFERRED EMBODIMENT

Referring now to Fig. 1 of the drawing, a simplified embodiment of a relational break signal generating device in accordance with the present invention is schematically illustrated. As set out by the dashed lines, the device generally includes a first relational comparator circuit 10, a second relational comparator circuit 12, a combinational logic circuit 14 and a pulse generating circuit 16.

Generally stated, the relational comparators 10 and 12 selectively check for conditions

(1)  $A < X$ ,  $A = X$ ,  $A > X$

and

(2)  $B < X$ ,  $B = X$ ,  $B > X$

and the combinational logic 14 checks for the condition

(3)  $A < X < B$ .

A and B are preset words with a binary or binary-coded decimal value and are defined by the system operator and entered into the comparators from a console device (not shown).

X is a rapidly changing word with a binary or binary-coded decimal magnitude. A validity signal developed on an input terminal 44 and input to both comparator 10 and comparator 12 simultaneously indicates that a signal X is stable when it is high and that the results of the comparison being performed are valid. The outputs generated by comparators 10 and 12 are either enabled or disabled independently via B1ENB and BP2ENB signals which are applied to logic 14 via terminals 32 and 34, respectively.

The conditions (1) and (2) indicated above are called relational comparisons and the results of such comparisons are used to derive the "break region" comparison given in condition (3). Note that the conditions (1) and (2) contain as a subset thereof the traditional



-6-

break point concept  $A = X$  and  $B = X$  implemented in current in-circuit emulators, logic analyzers and program monitors.

The combinational logic contained in block 14 further discriminates between relational break and break region conditions and forms a single break signal output BK at terminal 36 which is used to trigger an event such as a break in emulation or a cessation of trace history in a logic analyzer. More specifically, comparator circuit 10 compares changing program memory addresses X input at a terminal 18 to a preselected reference address A which was previously input at DATØ terminal 20 and develops a break point signal BP1 at its output 22 when a preselected relationship exists between the program address X and the reference address A. The qualifier data indicating the preselected relationship ( $A < X$ ,  $A = X$  or  $A > X$ ) is also input to comparator circuit 10 via DATØ terminal 20.

Comparator circuit 12 functions in the same manner as circuit 10 and develops a second break point signal BP2 at its output 24 when a preselected relationship exists between the address X input at terminal 18 and a second preselected reference address B which is input at the DATØ terminal 26. The second preselected relationship is selected from one of the three relationships  $B < X$ ,  $B = X$  and  $B > X$ , and data corresponding thereto is also input to circuit 12 via DATØ line 26.

Logic circuit 14 includes combinational logic which responds to qualifier signals  $>BIT1$  and  $<BIT2$  applied at inputs 28 and 30, respectively, and break point enable signals BP1ENB and BP2ENB input at terminals 32 and 34, respectively, and combines the break point signals BP1 and BP2 input thereto at 22 and 24 to develop a break signal BK at output 36 when a preselected relationship exists between the input address X and the reference addresses A and B.





Pulse generating circuit 16 responds to the break point signals developed at 22 and 24, and generates an output pulse P1 at terminal 38 each time a break point signal BP1 is developed on line 22; generates an output pulse P2 at terminal 40 each time a break point signal BP2 is developed on line 24; and generates an output pulse region output pulse PR at terminal 42 each time pulses P1 and P2 exist simultaneously.

The comparator circuit 10 is comprised of a 16-bit shift register 50, a 3-bit shift register 52, a magnitude comparator 54, four NAND gates 56, 58, 60 and 62, and an AND gate 64. The shift registers 50 and 52 are serial input/parallel output registers into which reference data A is shifted via terminal 20 in response to clock pulses input at IOIW terminal 21. More particularly, the reference data is comprised of 3 bits of qualifying data which is input to register 52 and 16 bits of address data which is input to register 50.

Comparator 54 is a high-speed magnitude comparator which performs comparison of straight binary or BCD codes. It compares the reference data A contained in register 50 to the program data X input on line 18 and develops three fully decoded outputs on lines 66, 68 and 70. An output will be developed on line 66 if the magnitude of X is greater than the magnitude of A; an output will be developed on line 68 if the magnitude of X is equal to the magnitude of A; and an output will be developed on line 70 if the magnitude of X is less than A.

The outputs of comparator 54 are input to the NAND gates 56, 58 and 60, respectively, along with qualifying data from shift register 52, and as a result an output will be developed on one of the lines 72, 74 or 76 if a comparator output is generated which corresponds to the bit that is set in shift register 52. This will cause an output to be developed by NAND gate 62 on line 78 which is designated as a tentative break point TBPI and is

-8-

input to one side of AND gate 64. If a validity input is applied via terminal 44 to the other side of AND gate at the same time TBPl exists, a break point output TP1 will be developed at 22.

5           Comparator circuit 12 is identical to that of comparator circuit 10 and includes shift registers 80 and 82, a magnitude comparator 84, NAND gates 86, 88, 90 and 92, and an AND gate 94. Circuit 12 compares the reference data B input at terminal 26 to the program  
10 data X input at terminal 18, and if the specified conditions are met, develops a second break point signal BP2 at 24.

The combinational logic circuit 14 includes NAND gates 100, 102, 104 and 106, AND gates 108 and 110, a  
15 NOR gate 112, and an OR gate 114. The gates 100 and 102 receive the break point signals BP1 and BP2 respectively, along with the enable signals BP1ENB and BP2ENB, and develop outputs EBPl/ and EBP2/ if an output exists on lines 22 and 24 at the time that the enable  
20 signals are raised. The signals EBPl/ and EBP2/ are input to NAND gate 104 to develop an output on line 116 when the two signals exist simultaneously and such signal is input to one side of AND gate 108.

At the same time the signals EBPl/ and EBP2/ are  
25 applied to two of the inputs 118 and 120 of NOR gate 112. The >BIT1 input stored in register 52 is input to one side of NAND gate 106 while the <BIT2 stored in register 82 is input to the other side of NAND gate 106. An output developed by NAND gate 106 on line 112 is input  
30 to NOR gate 112. The same signal will also be input to AND gate 108 on line 124. If both inputs to AND gate 108 are true, then a relational break signal RB will be developed on line 126 for input to OR gate 114. In response to the signals EBPl/, EBP2/ and the output of  
35 NAND gate 106, NOR gate 112 will develop a break region signal BR for input to OR gate 114. In response to the

-9-

signals BR and/or RB an output will be developed by OR gate 114 for input to AND gate 110 and if gate 110 is enabled by a P USER MODE signal input on line 128, a break signal BK will be developed at output 36.

5 Pulse generator 16 includes an AND gate 130, the inputs of which are coupled across lines 22 and 24. Each time a break point signal BP1 is developed on line 22 a pulse P1 is developed at terminal 38, and each time a break point signal BP2 is developed on line 24 a pulse  
10 P2 is developed at terminal 40. And each time that both P1 and P2 exist simultaneously, AND gate 130 will cause a pulse PR to be developed at terminal 42.

To assist the reader in understanding operation of the present invention, the following table of  
15 definitions and list of possible break cases are given.

TABLE OF DEFINITIONS

IO1W --- Clock input to shift register in A  
 DATØ A --- Data input to shift register in A  
 BP1ENB --- Enable signal for BP1  
 20 X --- Variable word  
 Validity --- This signal when high indicates that X is valid  
 IO2W --- Clock input to shift register in B  
 DATØ B --- Data input to shift register in B  
 25 BP2ENB --- Enable signal for BP2  
 P USER MODE --- This signal when high enables the BK output  
 >BIT1 --- Enables/disables A < X for first relational comparator  
 30 =BIT1 --- Enables/disables A = X for first relational comparator  
 <BIT1 --- Enables/disables A > X for first relational comparator



-10-

A < X --- Output of magnitude comparator 54  
 A = X --- Output of magnitude comparator 54  
 A > X --- Output of magnitude comparator 54  
 TBP1 --- Tentative break point signal  
 5       BP1 --- Break point signal

>BIT2 --- Enables/disables A < X for second  
           relational comparator  
 =BIT2 --- Enables/disables A = X for second  
           relational comparator  
 10     <BIT2 --- Enables/disables A > X for second  
           relational comparator

B < X --- Output of comparator 84  
 B = X --- Output of comparator 84  
 B > X --- Output of comparator 84  
 15     TBP2 --- Tentative break point signal  
        PB2 --- Break point signal

EBP1/ --- Enabled and complemented break point  
           signal for relational comparator 10  
 EBP2/ --- Enabled and complemented break point  
 20     signal for relational comparator 12

BR --- Break region signal  
 RB --- Relational break signal  
 BK --- Break signal

P1 --- Relational strobe pulse  
 25     P2 --- Relational strobe pulse  
        PR --- Pulse region strobe pulse

LIST OF BREAK CASES

Case 1.\* If A = X then break.  
 Case 2. If A > X then break.  
 30     Case 3. If A < X then break.  
        Case 4.\* If B = X then break.



-11-

- Case 5. If  $B > X$  then break.
- Case 6. If  $B < X$  then break.
- Case 7. If  $A < X < B$  then break.
- Case 8. If  $A = X$  or  $B > X$  then break.
- 5 Case 9.\* If  $A = X$  or  $B = X$  then break.
- Case 10. If  $A = X$  or  $B < X$  then break.
- Case 11. If  $A < X$  or  $B > X$  then break.
- Case 12. If  $A < X$  or  $B = X$  then break.
- Case 13. If  $A < X$  or  $B < X$  then break.
- 10 Case 14. If  $A > X$  or  $B > X$  then break.
- Case 15. If  $A > X$  or  $B < X$  then break.
- Case 16. If  $A > X$  or  $B = X$  then break.
- Case 17.\* All breaks disabled.

Note that only the four cases marked with the  
15 asterisk (\*) are possible using conventional break logic.

Each of the above cases can be evaluated by  
inspection of the circuit using the following parameters:

Case 1. If  $A = X$  then break:

20           BP1ENB = 1                   BP2ENB = 0

          >BIT1 = 0                    >BIT2 = 0

          =BIT1 = 1                    =BIT2 = 0

          <BIT1 = 0                    <BIT2 = 0

          Validity = 1 when X is valid.

          TBP1 = 1                    TBP2 = 0

25           BP1 = 1                    BP2 = 0

          EBP1/ = 0                   EBP2/ = 1

          BR = 0

          RB = 1

          P USER MODE = 1

30           BK = 1



-12-

Case 2. If A &gt; X then break:

```

                    BP1ENB = 1          BP2ENB = 0
                    >BIT1 = 1          >BIT2 = 0
                    =BIT1 = 0          =BIT2 = 0
5                   <BIT1 = 0          <BIT2 = 0
                    Validity = 1 when X is valid.
                    TBP1 = 1           TBP2 = 0
                    BPI = 1            BP2 = 0
                    EBP1/ = 0          EBP2/ = 1
10                  RB = 1
                    BR = 0
                    P USER MODE = 1
                    BK = 1

```

Case 3. If A &lt; X then break:

```

15                  BP1ENB = 1          BP2ENB = 0
                    >BIT1 = 0          >BIT2 = 0
                    =BIT1 = 0          =BIT2 = 0
                    <BIT1 = 1          <BIT2 = 0
                    Validity = 1 when X is valid.
20                  TBP1 = 1           TBP2 = 0
                    BPI = 1            BP2 = 0
                    EBP1/ = 0          EBP2/ = 1
                    BR = 0
                    RB = 1
25                  P USER MODE = 1
                    BK = 1

```

Cases 4, 5 and 6 are the same as Cases 1, 2 and 3 because comparator circuit 12 is identical to comparator circuit 10.



-13-

Case 7. If  $A < X < B$  then break:

	BP1ENB = 1	BP2ENB = 1
	>BIT1 = 1	>BIT2 = 0
	=BIT1 = 0	=BIT2 = 0
5	<BIT1 = 0	<BIT2 = 1
	Validity = 1 when X is valid.	
	TBP1 = 1	TBP2 = 1
	BP1 = 1	BP2 = 1
	EBP1/ = 0	EBP2/ = 0
10	BR = 1	
	RB = 0	
	P USER MODE = 1	
	BK = 1	

Cases 8 through 16 are variants of Case 7.

15 Case 17. All breaks may be disabled by setting  
BP1ENB = BP2ENB = 0.

In addition to the above, it is also of interest to note the following list of pulse outputs generated by circuit 16 and corresponding to the various break cases.

20

LIST OF PULSE CASES

	Case 1. If $A = X$ then P1.
	Case 2. If $A > X$ then P1.
	Case 3. If $A < X$ then P1.
	Case 4. If $B = X$ then P2.
25	Case 5. If $B > X$ then P2.
	Case 6. If $B < X$ then P2.
	Case 7. If $A < X < B$ then PR, P1, P2.
	Case 8. If $A = X$ or $B > X$ then P1 or P2.
	Case 9. If $A = X$ or $B = X$ then P1 or P2.
30	Case 10. If $A = X$ or $B < X$ then P1 or P2.
	Case 11. If $A < X$ or $B > X$ then P1 or P2.



-14-

- Case 12. If  $A < X$  or  $B = X$  then P1 or P2.  
Case 13. If  $A < X$  or  $B < X$  then P1 or P2.  
Case 14. If  $A > X$  or  $B > X$  then P1 or P2.  
Case 15. If  $A > X$  or  $B < X$  then P1 or P2.  
5 Case 16. If  $A > X$  or  $B = X$  then P1 or P2.  
Case 17. Pulses may be enabled or disabled by  
external gates and registers.

It should be noted that the pulse outputs are  
always enabled even during the time that break points  
10 are enabled or disabled. Furthermore, these pulse outputs  
or strobe signals may be input to frequency counters,  
oscilloscope triggers, logic analyzer triggers or any  
other TTL compatible logic. Possible uses of such  
signals are

- 15 (1) to provide a determination of how many  
times a given subroutine is called  
during the execution of a program;  
(2) to provide an indication of the  
percentage of stack references to  
20 execution time; and  
(3) to provide a display of program timing.

Even though the present invention has been  
described above with relation to a preferred but  
simplified embodiment, it is to be understood that as  
25 actually implemented the device will most likely include  
additional qualifying logic appropriate to a particular  
application. Moreover, it is contemplated that the  
present invention can be extended to have the capability  
of making even more complex comparisons involving more  
30 than one variable X. For example, if two variables are  
to be considered, as in an instruction such as "If  
( $A < X < B$ ) and ( $C < Y < D$ ) then break," the outputs  
of two such circuits as described above would be AND'd  
together. Higher pluralities of variables could likewise  
35 be accommodated in the same manner.





-15-

Although numerous alterations and modifications of the preferred embodiment will no doubt become apparent to those skilled in the art after having read the above description, it is intended that the appended claims  
5 not be limited by such description but be integrated as covering all such alterations and modifications as fall within the true spirit and scope of the invention.

What is claimed is:



-16-

Claims

1. A relational break signal generating device comprising:

5 first relational comparing means for comparing a variable input signal X to a first reference signal A and for developing a first break point signal when certain first qualifying conditions are met;

10 second relational comparing means for comparing said variable input signal X to a second reference signal B and for developing a second break point signal when certain second qualifying conditions are met; and

15 combinational logic means for monitoring said first and second break point signals and for generating a break signal when certain third qualifying conditions are met.

2. A relational break signal generating device as recited in claim 1 wherein said first comparing means includes

20 a first magnitude comparator for comparing said variable input signal X to said first reference signal A and for developing a first comparison signal if  $A < X$ , and second comparison signal if  $A = X$ , and a third comparison signal if  $A > X$ , and

25 means for enabling a selected one of said comparison signals to cause said first break point signal to be developed.



-17-

3. A relational break signal generating device as recited in claim 2 wherein said second comparing means includes

5 a second magnitude comparator for comparing said variable input signal X to said second reference signal B and for developing a fourth comparison signal if  $B < X$ , a fifth comparison signal if  $B = X$ , and a sixth comparison signal if  $B > X$ , and

10 means for enabling a selected one of said comparison signals to cause said second break point signal to be developed.

4. A relational break signal generating device as recited in claim 1 and further comprising:

15 pulse generating means for generating a first output signal pulse each time said first break point signal is generated, a second output signal pulse each time said second break point signal is generated, and a third output signal pulse each time said first break point signal and said second break point signal are  
20 generated simultaneously.

5. A relational break signal generating device as recited in claim 1, 2, 3 or 4 wherein said combinational logic means includes means for developing a break region signal BR when any of several predetermined  
25 relationships exist between said first break point signal, said second break point signal and said third qualifying conditions.



-18-

6. A relational break signal generating device as recited in claim 1, 2, 3 or 4 wherein said combinational logic means includes means for developing a relational break signal RB when any of several predetermined relationships exist between said first break point signal, said second break point signal and said third qualifying conditions.

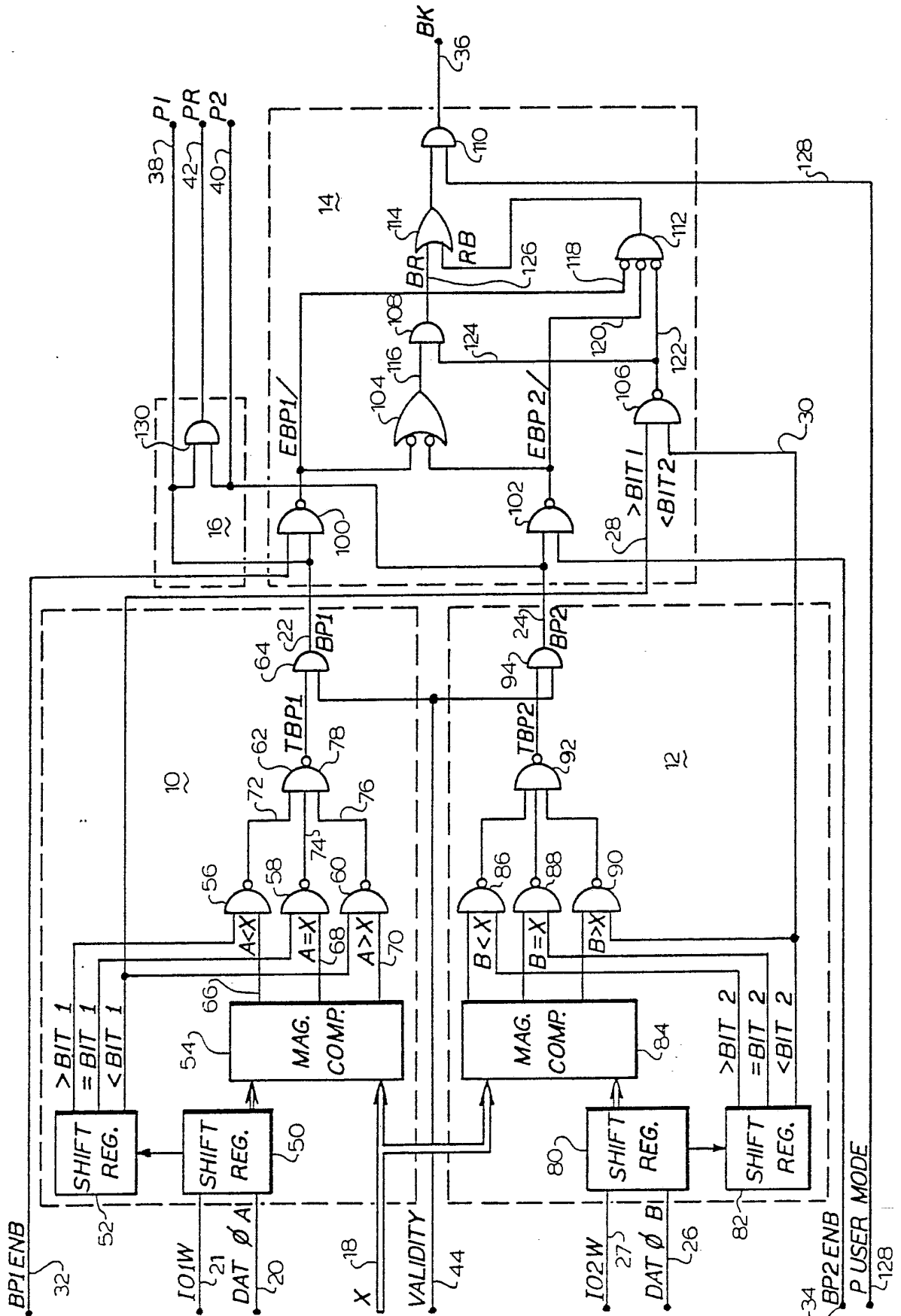
7. A relational break signal generating device as recited in claim 1, 2, 3 or 4 wherein said combinational logic means includes

first logic circuitry for developing a break region signal BR when any of said predetermined relationships exist between said first break point signal, said second break point signal and said qualifying conditions, and

second logic circuitry for generating a relational break signal RB whenever any of several predetermined relationships exist between said first break point signal, said second break point signal and said third qualifying conditions.

8. A relational break signal generating device as recited in claim 7 and further including third logic circuitry for developing said break signal whenever either said break region signal BR or said relational break signal RB is developed.





## INTERNATIONAL SEARCH REPORT

International Application No PCT/US80/00446

<b>I. CLASSIFICATION OF SUBJECT MATTER</b> (If several classification symbols apply, indicate all) <sup>3</sup>				
According to International Patent Classification (IPC) or to both National Classification and IPC				
INT. CL. <sup>3</sup> G06 F 7/00; 7/22; 9/00;				
US. CL. 364/200; 364/900; 371/15; 371/16; 371/17; 18, 19				
<b>II. FIELDS SEARCHED</b>				
Minimum Documentation Searched <sup>4</sup>				
Classification System	Classification Symbols			
US.	364/200 364/900 371/15; 371/16; 371/17; 371/18; 371/19			
Documentation Searched other than Minimum Documentation to the Extent that such Documents are Included in the Fields Searched <sup>5</sup>				
<b>III. DOCUMENTS CONSIDERED TO BE RELEVANT</b> <sup>14</sup>				
Category <sup>6</sup>	Citation of Document, <sup>15</sup> with indication, where appropriate, of the relevant passages <sup>17</sup>	Relevant to Claim No. <sup>18</sup>		
X	U.S., A. 3,576,541 Published 27 April 1971	1-8		
X	U.S., A. 3,937,938 Published 10 February 1976	1-8		
X	U.S., A. 3,427,443 Published 11 February 1969	1-8		
X	U.S., A. 3,415,981 Published 10 December 1968	1-8		
X	U.S., A. 3,771,131 Published 6 November 1973	1-8		
A	DIGITAL LOGIC HANDBOOK published 1969, DIGITAL EQUIPMENT CORPORATION	1-8		
<p><sup>15</sup> * Special categories of cited documents:</p> <table style="width: 100%; border: none;"> <tr> <td style="width: 50%; border: none;"> <p>"A" document defining the general state of the art</p> <p>"E" earlier document but published on or after the international filing date</p> <p>"L" document cited for special reason other than those referred to in the other categories</p> <p>"O" document referring to an oral disclosure, use, exhibition or other means</p> </td> <td style="width: 50%; border: none;"> <p>"P" document published prior to the international filing date but on or after the priority date claimed</p> <p>"T" later document published on or after the international filing date or priority date and not in conflict with the application, but cited to understand the principle or theory underlying the invention</p> <p>"X" document of particular relevance</p> </td> </tr> </table>			<p>"A" document defining the general state of the art</p> <p>"E" earlier document but published on or after the international filing date</p> <p>"L" document cited for special reason other than those referred to in the other categories</p> <p>"O" document referring to an oral disclosure, use, exhibition or other means</p>	<p>"P" document published prior to the international filing date but on or after the priority date claimed</p> <p>"T" later document published on or after the international filing date or priority date and not in conflict with the application, but cited to understand the principle or theory underlying the invention</p> <p>"X" document of particular relevance</p>
<p>"A" document defining the general state of the art</p> <p>"E" earlier document but published on or after the international filing date</p> <p>"L" document cited for special reason other than those referred to in the other categories</p> <p>"O" document referring to an oral disclosure, use, exhibition or other means</p>	<p>"P" document published prior to the international filing date but on or after the priority date claimed</p> <p>"T" later document published on or after the international filing date or priority date and not in conflict with the application, but cited to understand the principle or theory underlying the invention</p> <p>"X" document of particular relevance</p>			
<b>IV. CERTIFICATION</b>				
Date of the Actual Completion of the International Search <sup>2</sup>	Date of Mailing of this International Search Report <sup>2</sup>			
27 March 1981	01 MAY 1981			
International Searching Authority <sup>1</sup>	Signature of Authorized Officer <sup>20</sup>			
ISA/US	